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#### Edge profile and stability analysis as **Edge-Localized Modes (ELMs) disappear** with increasing lithium wall coatings in NSTX



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Lithium wall coatings control recycling and edge density, and lead to ELM-free H-mode

- Analysis of a well-controlled lithium coating sequence in which ELMs gradually disappear
  - Edge density, temperature, and pressure profiles are modified with lithium
- Edge peak pressure gradient moves farther from separatrix, and pedestal gets wider
  - Causes change in calculated bootstrap current
  - Edge stability improved



#### H-mode leads to instabilities called Edge-Localized Modes (ELMs)



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### ELMs: The good, the bad, and the ugly

- The good: Eject impurities
- The bad: Erosion, melting, and cracking of plasma facing components (PFCs), reduced confinement
- The ugly: Large ELMs very destructive
  - ITER needs a small or no ELM regime to ensure PFC integrity
  - Requires  $\Delta W_{ELM}/W_{TOTAL} \le 0.3\%$ for steady ELMs
  - No Large ELMs allowed!





Zhitlukin, Linke PSI 2006



#### Different types of ELM cycles can be envisioned



- ELMs triggered by peeling-ballooning modes, ELM size correlates to depth of most unstable mode and to location in parameter space
- Pressure rises up on transport time scale between ELMs, current rises to steady state value more slowly
- Predict changeover in ELM behavior when  $J_{ped} < J_{peel} \Rightarrow$  strong density and shape dependence







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#### **NSTX lithium wall coatings induce ELM-free H-mode**



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#### **ELM evolution with shot number**



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#### **Quiescent phases increase with increasing lithium coating**



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#### How does lithium make ELMs go away?

- How are n, T, P, J profiles different?
- How is the edge stability different?
- How do stability calculations reflect changes in ELM behavior?



## Edge profile & stability analysis procedure

- EFIT equilibrium reconstruction code run at Thomson scattering (TS) profile times for flux ( $\psi_N$ ) mapping
- Profile fitting with multiple time slices
  - Pre-lithium discharge profiles from last 20-70% of ELM cycle selected
  - Post-lithium discharge profiles used in 100-200 msec windows
- Free boundary kinetic EFITs run to match pressure & current profiles
  - Edge bootstrap current computed from Sauter neoclassical model
    - No direct measurement biggest uncertainty
  - Stability evaluated with PEST code
- Fixed boundary kinetic EFITs run with variations of edge pressure gradient and edge current
  - Stability boundary evaluated with ELITE code

#### Multiple TS profiles combined for better edge resolution

- ELM free shots combined over ~100 ms window
- ELMy shots combined using ELM syncing
   only use data from end of ELM cycle
- CHERS, magnetics data also combined



#### **ELM-free pedestals wider, higher**



Shot 129015 (ELMy) Shot 129030 (Less ELMy) Shot 129038 (ELM-free)



#### ELMy to ELM-free transition ordered by n<sub>e</sub> and P pedestal width



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# Kinetic EFITs reconstruct equilibria using additional constraints

- Constrained by measured P, J profiles
  - Bootstrap current
    calculated from
    neo-classical model

 $\mathbf{J}_{BS} \propto \nabla n, \nabla T$ 



- PEST code uses EFITs to calculate growth rates
  - Uses Ideal MHD
  - Not limited to edge instabilities so caution necessary





## Fixed boundary-kinetic EFITs + ELITE give stability diagram

- Edge pressure gradient, currents scaled for new kinetic EFITs
  - Uses fixed-boundary from original kinetic EFIT
  - Can also scale *n*, *T*, W,  $v^*$  or shift  $n_e$ ,  $T_e$ ,  $P_e$  pedestal
- ELITE code calculates stability for each combination of P'<sub>ped</sub> and J<sub>ped</sub>
  - Only sensitive to edge instabilities
  - Gives stability diagram



## Close to instability threshold when plasma is ELMy





#### Stability boundary shifts after some lithium but ELMs continue



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#### Farther from instability threshold when ELM-free



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## Conclusions

- Lithium wall coatings in NSTX gradually reduced, then completely eliminated ELMs
  - ELM-free plasmas have wider n<sub>e</sub> pedestals
  - Also have wider & higher  $P_e$  & P pedestals
  - Peak pressure gradient shifted inward
  - n<sub>e</sub> pedestal gradient reduced with increasing lithium
  - Edge T<sub>e</sub>, T<sub>i</sub> increase and profiles change substantially
- ELM-free plasmas are farther from the edge stability boundary
  - Both boundaries and profiles move as lithium added



#### Density profile modification due to lithium pumping is the key in changing edge stability





## **Future Work**

- Calculate stability while varying model profiles
- Why are the ELMs not stabilized by diamagnetic drift, as in higher aspect ratio tokamaks?
  - Low growth rates:  $\gamma_{lin}/\omega_A \ge 1\%$  unstable experimentally
  - Should be stabilized by diamagnetic drift:  $\gamma_{lin}/(\omega^*/2) \le 5-10\%$
- Why do ELMs go away the way they do i.e. with increasing periods of quiescence?
  - Details of density/pressure profile modification may be beyond present ability to measure experimentally
    - Additional Thomson channels being installed for 2011
    - Better edge resolution could make multiple TS times unnecessary
  - How do profiles and stability evolve through ELM cycle?

## EFITs require setting outboard T<sub>e</sub> at separatrix for flux mapping of Thomson scattering profiles



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